**ON Semiconductor** 

Is Now

# Onsemi

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# MOSFET – Power, Single, N-Channel, DPAK/IPAK 25 V, 65 A

#### Features

- Trench Technology
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These are Pb–Free Devices

## Applications

- VCORE Applications
- DC-DC Converters
- High/Low Side Switching

# **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise stated)

Para	Parameter				
Drain-to-Source Vo	V <sub>DSS</sub>	25	V		
Gate-to-Source Vol	tage		V <sub>GS</sub>	±20	V
Continuous Drain		$T_A = 25^{\circ}C$	Ι <sub>D</sub>	13	А
Current R <sub>0JA</sub> (Note 1)		T <sub>A</sub> = 85°C		10	
Power Dissipation $R_{\theta JA}$ (Note 1)		T <sub>A</sub> = 25°C	PD	2.0	W
Continuous Drain Current R <sub>θJA</sub>		T <sub>A</sub> = 25°C	ID	10.4	А
(Note 2)	Steady State	T <sub>A</sub> = 85°C		8.0	
Power Dissipation $R_{\theta JA}$ (Note 2)	Sidle	$T_A = 25^{\circ}C$	PD	1.28	W
Continuous Drain Current $R_{\theta JC}$		$T_C = 25^{\circ}C$	۱ <sub>D</sub>	65	А
(Note 1)		$T_{C} = 85^{\circ}C$		50	
Power Dissipation $R_{\theta JC}$ (Note 1)		T <sub>C</sub> = 25°C	PD	50	W
Pulsed Drain Current	t <sub>p</sub> =10μs	$T_A = 25^{\circ}C$	I <sub>DM</sub>	130	A
Current Limited by P	ackage	$T_A = 25^{\circ}C$	I <sub>DmaxPkg</sub>	45	А
Operating Junction a Temperature	Operating Junction and Storage Temperature				°C
Source Current (Bod	ly Diode)		۱ <sub>S</sub>	42	А
Drain to Source dV/c	dV/dt	6	V/ns		
$ \begin{array}{l} \mbox{Single Pulse Drain-to-Source Avalanche} \\ \mbox{Energy } (T_J = 25^\circ C,  V_{DD} = 50 \mbox{ V},  V_{GS} = 10 \mbox{ V}, \\ \mbox{I}_L = 13 \mbox{ Apk},  L = 1.0 \mbox{ mH},  R_G = 25 \ \Omega) \end{array} $			EAS	84.5	mJ
Lead Temperature for (1/8" from case for 1		Purposes	ΤL	260	°C

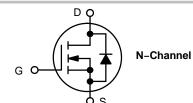
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

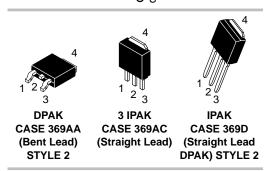


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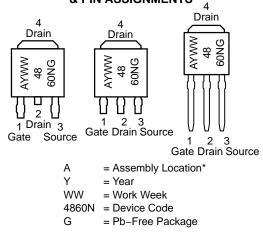
#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
25 V	7.5 mΩ @ 10 V	65 A
	11.1 mΩ @ 4.5 V	03 A





#### MARKING DIAGRAMS & PIN ASSIGNMENTS



\* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

# ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit	
Junction-to-Case (Drain)	$R_{\theta JC}$	3		
Junction-to-TAB (Drain)	$R_{\thetaJC-TAB}$	3.5	°C/W	
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	75	°C/W	
Junction-to-Ambient - Steady State (Note 2)	$R_{ extsf{ heta}JA}$	117		

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

Parameter	Symbol	Test Cond	lition	Min	Тур	Мах	Unit
OFF CHARACTERISTICS						-	-
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 V, I_D$	= 250 μA	25			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>				21		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$			1.0	
		V <sub>DS</sub> = 20 V	T <sub>J</sub> = 125°C			10	-μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS}$	<sub>S</sub> = ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)	-					-	-
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D}$	= 250 μA	1.45		2.5	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				5.2		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 30 A		6.1	7.5	7.5 11.1 mΩ
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 30 A		8.9	11.1	
Forward Transconductance	9fs	V <sub>DS</sub> = 1.5 V,	I <sub>D</sub> = 15 A		48		S
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>				1308		
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1.0 M	Hz, V <sub>DS</sub> = 12 V		342		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				169		
Total Gate Charge	Q <sub>G(TOT)</sub>				11	16.5	
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V, I <sub>D</sub> = 30 A			1.2		
Gate-to-Source Charge	Q <sub>GS</sub>				3.9		nC
Gate-to-Drain Charge	Q <sub>GD</sub>				4.7		1
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 15 V, $I_{D}$ = 30 A			21.8		nC
SWITCHING CHARACTERISTICS (Note	4)			-		-	-
Turn On Dolou Time	+				10.0	1	1

Turn-On Delay Time	t <sub>d(ON)</sub>		12.2	
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V,	20.1	20
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_{D} = 15 \text{ A}, \text{ R}_{G} = 3.0 \Omega$	15.2	ns
Fall Time	t <sub>f</sub>		4.3	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%. 4. Switching characteristics are independent of operating junction temperatures.

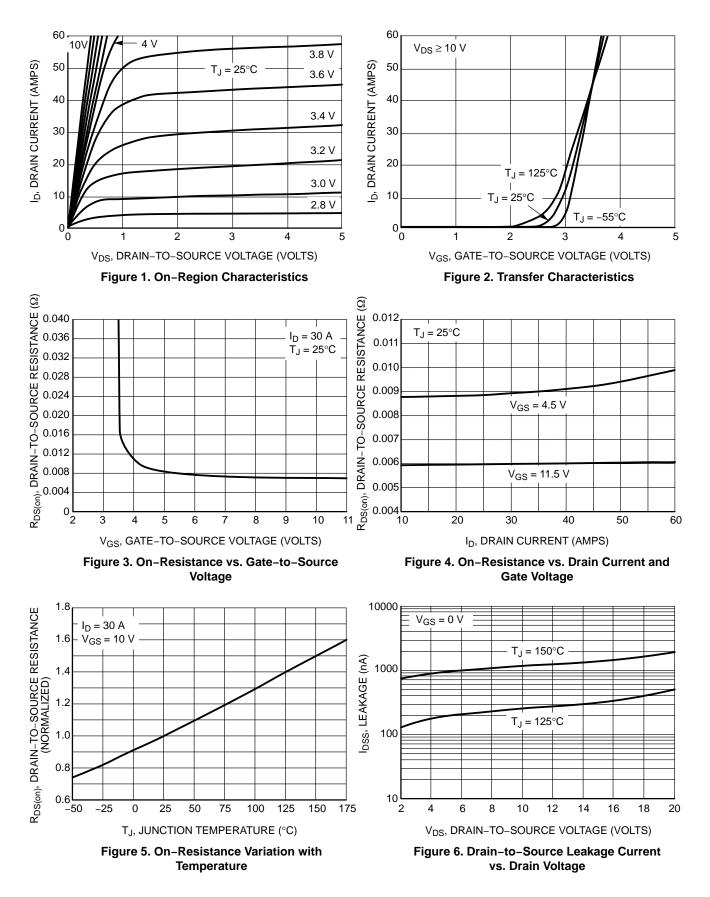
### ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise specified) (continued)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (	Note 4)						
Turn-On Delay Time	t <sub>d(ON)</sub>				7.1		
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 11.5 V, V	′ <sub>DS</sub> = 15 V,		17		ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>	V <sub>GS</sub> = 11.5 V, V I <sub>D</sub> = 15 A, R <sub>G</sub>	= 3.0 Ω		22		
Fall Time	t <sub>f</sub>				2.3		
DRAIN-SOURCE DIODE CHARACT	ERISTICS			-			-
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 V, \\ I_{S} = 30 A \\ T_{J} = 25^{\circ}C \\ T_{J} = 125^{\circ}C$	$T_J = 25^{\circ}C$		0.9	1.2	V
				0.76		v	
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dIS/dt = 100 A/μs, I <sub>S</sub> = 30 A			12.7		
Charge Time	t <sub>a</sub>				7.0		ns
Discharge Time	t <sub>b</sub>				5.7		
Reverse Recovery Charge	Q <sub>RR</sub>				3.5		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L <sub>S</sub>				2.49		
Drain Inductance, DPAK	L <sub>D</sub>	T <sub>A</sub> = 25°C			0.0164		
Drain Inductance, IPAK	L <sub>D</sub>				1.88		nH
Gate Inductance	L <sub>G</sub>				3.46		
Gate Resistance	R <sub>G</sub>				0.75		Ω

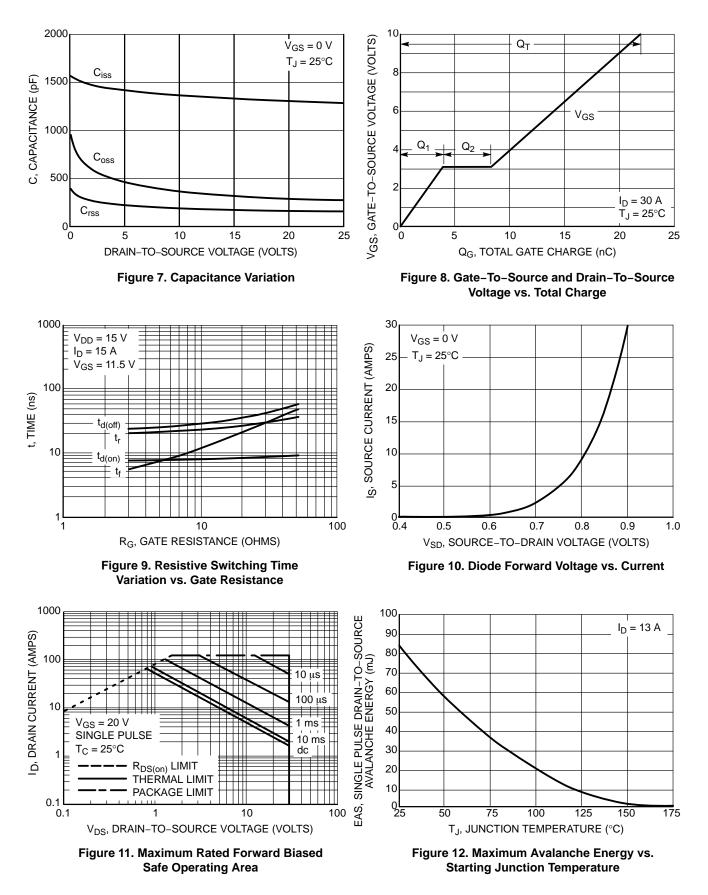
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 3. Pulse Test: pulse width  $\leq$  300 µs, duty cycle  $\leq$  2%.

4. Switching characteristics are independent of operating junction temperatures.

# **TYPICAL PERFORMANCE CURVES**



# **TYPICAL PERFORMANCE CURVES**



# TYPICAL PERFORMANCE CURVES

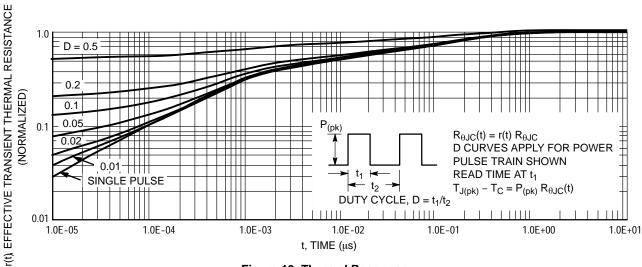


Figure 13. Thermal Response

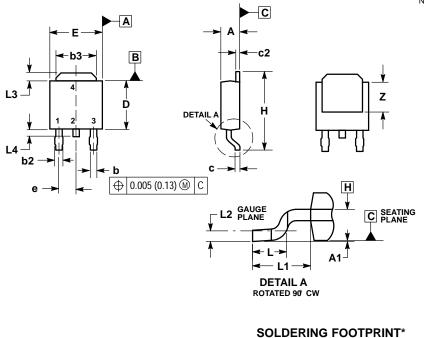
#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTD4860NT4G	DPAK (Pb-Free)	2500 / Tape & Reel
NTD4860N-1G	IPAK (Pb-Free)	75 Units / Rail
NTD4860N-35G	IPAK Trimmed Lead (3.5 ± 0.15 mm) (Pb-Free)	75 Units / Rail

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS

DPAK (SINGLE GUAGE) CASE 369AA **ISSUE B** 

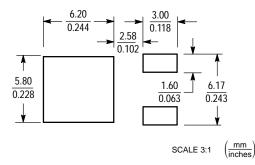


- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  2. CONTROLLING DIMENSION: INCHES.
  3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS D3, L3 and Z.
  4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
  5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
  6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.
- PLANE H.

	INC	HES	MILLIM	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
Е	0.250	0.265	6.35	6.73
е	0.090	BSC	2.29 BSC	
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.108	REF	2.74	REF
L2	0.020 BSC		0.51	BSC
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Ζ	0.155		3.93	



STYLE 2:

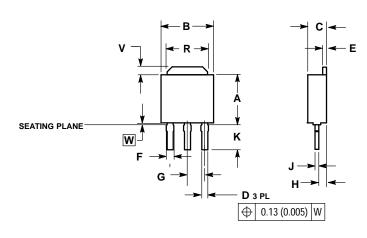


\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### PACKAGE DIMENSIONS

#### **3 IPAK, STRAIGHT LEAD** CASE 369AC

ISSUE O



SEATING PLANE IS ON TOP OF DAMBAR POSITION. DIMENSION A DOES NOT INCLUDE DAMBAR POSITION OR MOLD GATE. 4 INCHES MILLIMETERS 
 MIN
 MAX

 0.235
 0.245
 DIM MIN MAX Α 0.235 5.97 6.22 **B** 0.250 0.265 6.35 6.73 **C** 0.086 0.094 2.19 2.38 **D** 0.027 0.035 0.69 0.88 Е 0.018 0.023 0.46 0.58 **F** 0.037 0.043 0.94 1.09 G 0.090 BSC 2.29 BSC H 0.034 0.040 0.87 1.01 **J** 0.018 0.023 0.46 0.58 ĸ 0.134 0.142 3.40 3.60 
 R
 0.180
 0.215

 V
 0.035
 0.050
 4.57 5.46 1.27 0.89 **W** 0.000 0.010 0.000 0.25

NOTES: 1.. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: INCH.

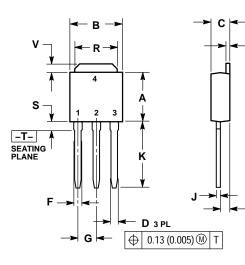
2

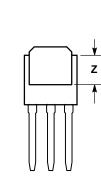
3.

IPAK CASE 369D **ISSUE C** 

Ε

·H





NOTES 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

	INC	HES	MILLIN	ETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090	) BSC	2.29 BSC	
н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
ĸ	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
V	0.035	0.050	0.89	1.27
Z	0.155		3.93	

STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

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